IGBT - Field Stop, Trench

75 A, 650 V

FGHL75T65LQDT

Description

Field stop 4th generation Low Vce(sat) IGBT technology and Full current rated copak Diode technology.

Features

- Maximum Junction Temperature: $T_J = 175^{\circ}C$
- Positive Temperature Co-efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage: $V_{CE(Sat)} = 1.15 \text{ V (Typ.)} @ I_C = 75 \text{ A}$
- 100% Of The Part Are Tested For I_{LM} (Note 2)
- Smooth & Optimized Switching
- Tight Parameter Distribution
- Co-Packed With Soft And Fast Recovery Diode
- RoHS Compliant

Typical Applications

- Solar Inverter
- UPS, ESS
- PFC, Converters

MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Collector to Emitter Voltage	V _{CES}	650	V
Gate to Emitter Voltage	V _{GES}	±20	V
Transient Gate to Emitter Voltage		±30	
Collector Current @ T _C = 25°C (Note 1)	I _C	80	Α
Collector Current @ T _C = 100°C		75	
Pulsed Collector Current (Note 2)	I _{LM}	300	Α
Pulsed Collector Current (Note 3)	I _{CM}	300	Α
Diode Forward Current @ T _C = 25°C (Note 1)	Ι _F	80	Α
Diode Forward Current @ T _C = 100°C		75	
Pulsed Diode Maximum Forward Current	I _{FM}	300	Α
Maximum Power Dissipation @ T _C = 25°C	P_{D}	469	W
Maximum Power Dissipation @ T _C = 100°C		234	
Operating Junction Temperature / Storage Temperature Range	T _J , T _{STG}	-55 to +175	°C
Maximum Lead Temp. For soldering Purposes, 1/8" from case for 5 seconds	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

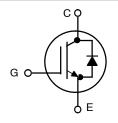
- 1. Value limit by bond wire.
- 2. V_{CC} = 400 V, V_{GE} = 15 V, I_{C} = 300 A, Inductive Load, 100% Tested. 3. Repetitive rating: pulse width limited by max. Junction temperature.

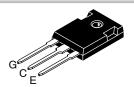


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V _{CES}	lc	V _{CE(Sat)}
650 V	75 A	1.15 V





TO-247-3L CASE 340CX

MARKING DIAGRAM



= ON Semiconductor Logo \$Y &Z = Assembly Plant Code &3 = 3-Digit Data Code

= 2-Digit Lot Traceability Code FGHL75T65LQDT = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping
FGHL75T65LQDT	TO-247-3L	30 Units / Rail

THERMAL CHARACTERISTICS

Parameter	Symbol	Value	Units
Thermal Resistance Junction to Case, for IGBT	$R_{ heta JC}$	0.32	°C/W
Thermal Resistance Junction to Case, for Diode	$R_{ heta JC}$	0.6	°C/W
Thermal Resistance Junction to Ambient	$R_{ heta JA}$	40	°C/W

ELECTRICAL CHARACTERISTICS (T_{.I} = 25°C unless otherwise noted)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS				•	•	
Collector-emitter Breakdown Voltage, Gate-emitter Short-circuited	V _{GE} = 0 V, I _C = 1mA	BV _{CES}	650	-	-	V
Temperature Coefficient of Breakdown Voltage	V _{GE} = 0 V, I _C = 1mA	ΔBV _{CES} /ΔT _J	_	0.6	-	V/°C
Collector-emitter Cut-off Current, Gate-emitter Short-circuited	V _{GE} = 0 V, V _{CE} = 650 V	I _{CES}	-	-	250	μΑ
Gate Leakage Current, Collector-emitter Short-circuited	V _{GE} = 20 V, V _{CE} = 0 V	I _{GES}	_	-	±400	nA
ON CHARACTERISTICS	•		•	•		•
Gate-emitter Threshold Voltage	$V_{GE} = V_{CE}$, $I_C = 75$ mA	V _{GE(th)}	3.0	4.5	6.0	V
Collector-emitter Saturation Voltage	V _{GE} = 15 V, I _C = 75 A, T _J = 25°C	V _{CE(sat)}	-	1.15	1.35	V
	V _{GE} = 15 V, I _C = 75 A, T _J = 175°C		_	1.22	_	1
DYNAMIC CHARACTERISTICS	•		•	•		•
Input Capacitance	V _{CE} = 30 V, V _{GE} = 0 V, f = 1 MHz	C _{ies}	-	15300	_	pF
Output Capacitance	7	C _{oes}	-	181	_	
Reverse Transfer Capacitance	7	C _{res}	_	68	_	
Gate Charge Total	V _{CE} = 400 V, I _C = 75 A, V _{GE} = 15 V	Qg	-	793	_	nC
Gate to Emitter Charge	7	Q _{ge}	-	72	_	
Gate to Collector Charge	7	Q _{gc}	-	248	_	
SWITCHING CHARACTERISTICS, INDUCT	TIVE LOAD				-	•
Turn-on Delay Time	T _J = 25°C	t _{d(on)}	-	45	_	ns
Rise Time	$V_{CC} = 400 \text{ V, } I_{C} = 37.5 \text{ A}$ $Rg = 4.7 \Omega$	t _r	_	20	_	
Turn-off Delay Time	V _{GE} = 15 V	t _{d(off)}	-	608	-	
Fall Time	7	t _f	-	160	_	
Turn-on Switching Loss	7	E _{on}	-	0.78	_	mJ
Turn-off Switching Loss	7	E _{off}	-	1.36	_	
Total Switching Loss	7	E _{ts}	-	2.14	_	
Turn-on Delay Time	T _J = 25°C	t _{d(on)}	-	48	-	ns
Rise Time	$V_{CC} = 400 \text{ V, } I_{C} = 75 \text{ A}$ Rg = 4.7 Ω	t _r	-	40	-	
Turn-off Delay Time	V _{GE} = 15 V	t _{d(off)}	-	568	-	
Fall Time		t _f	-	128	-	
Turn-on Switching Loss		E _{on}	-	1.88	-	mJ
Turn-off Switching Loss		E _{off}	-	2.38	-	
Total Switching Loss	7	E _{ts}	_	4.26	_	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted) (continued)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS, INDI	UCTIVE LOAD	•		•		•
Turn-on Delay Time	T _J = 175°C	t _{d(on)}	_	44	_	ns
Rise Time	$V_{CC} = 400 \text{ V, I}_{C} = 37.5 \text{ A}$ $Rg = 4.7 \Omega$	t _r	-	24	-	1
Turn-off Delay Time	V _{GE} = 15 V	t _{d(off)}	-	680	-	1
Fall Time		t _f	-	256	_	1
Turn-on Switching Loss		E _{on}	-	1.54	-	mJ
Turn-off Switching Loss		E _{off}	_	2.11	_	
Total Switching Loss		E _{ts}	-	3.65	_	1
Turn-on Delay Time	T _J = 175°C	t _{d(on)}	-	44	-	ns
Rise Time	$V_{CC} = 400 \text{ V, I}_{C} = 75 \text{ A}$ Rg = 4.7 Ω	t _r	-	44	-	1
Turn-off Delay Time	V _{GE} = 15 V	t _{d(off)}	-	632	-	1
Fall Time		t _f	-	184	-	1
Turn-on Switching Loss		E _{on}	-	3.14	-	mJ
Turn-off Switching Loss		E _{off}	-	3.58	_	
Total Switching Loss		E _{ts}	-	6.72	_	
DIODE CHARACTERISTICS						
Diode Forward Voltage	I _F = 75 A, T _J = 25°C	V _F	-	1.65	2.1	V
	I _F = 75 A, T _J = 175°C		_	1.55	-	
Reverse Recovery Energy	T _J = 25°C,	Erec	-	105	-	μJ
Reverse Recovery Time	V _R = 400 V, I _F = 37.5 A, di _F /dt = 1000 A/μs	Trr	-	59	-	ns
Reverse Recovery Charge		Qrr	-	574	-	nC
Reverse Recovery Current		Irr	-	20	-	Α
Reverse Recovery Energy	T _J = 25°C,	Erec	-	152	-	μJ
Reverse Recovery Time	V _R = 400 V, I _F = 75 A, di _F /dt = 1000 A/μs	Trr	-	87	-	ns
Reverse Recovery Charge		Qrr	-	794	-	nC
Reverse Recovery Current		Irr	-	18	-	Α
Reverse Recovery Energy	T _J = 175°C,	Erec	-	550	-	μJ
Reverse Recovery Time	V _R = 400 V, I _F = 37.5 A, di _F /dt = 1000 A/μs	Trr	-	119	_	ns
Reverse Recovery Charge		Qrr	-	2154	_	nC
Reverse Recovery Current		Irr	-	36	-	Α
Reverse Recovery Energy	T _J = 175°C,	Erec	_	764	-	μJ
Reverse Recovery Time	V _R = 400 V, I _F = 75 A, di _F /dt = 1000 A/μs	Trr	_	145	-	ns
Reverse Recovery Charge		Qrr	_	2947	-	nC
Reverse Recovery Current		Irr	-	40	-	Α

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

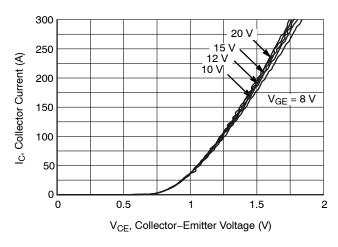


Figure 1. Typical Output Characteristics $(T_J = 25^{\circ}C)$

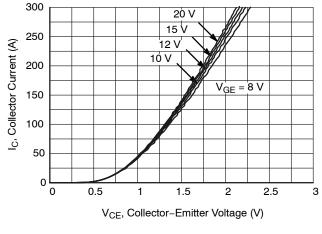


Figure 2. Typical Output Characteristics $(T_J = 175^{\circ}C)$

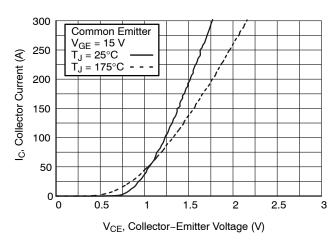


Figure 3. Typical Saturation Voltage Characteristics

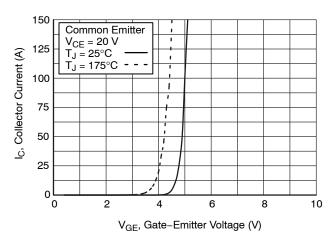


Figure 4. Typical Transfer Characteristics

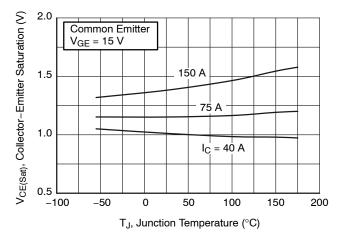


Figure 5. Saturation Voltage vs. Junction Temperature

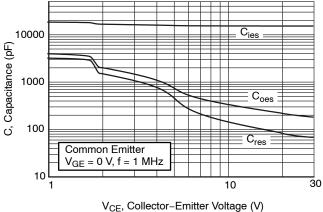


Figure 6. Capacitance Characteristics

TYPICAL CHARACTERISTICS (continued)

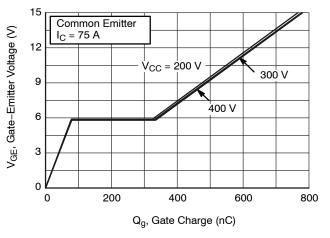
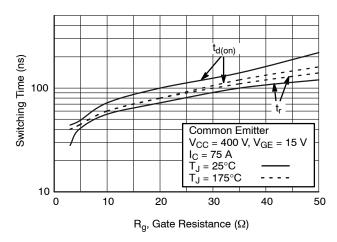


Figure 7. Gate Charge Characteristics

Figure 8. SOA Characteristics



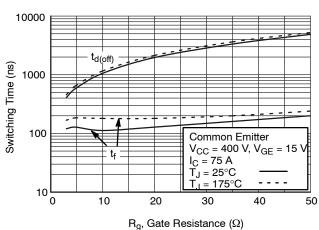
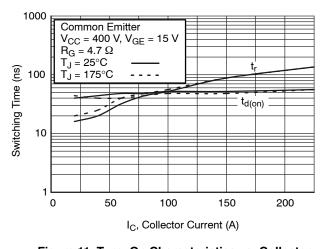


Figure 9. Turn-On Characteristics vs. Gate Resistance

Figure 10. Turn-Off Characteristics vs. Gate Resistance



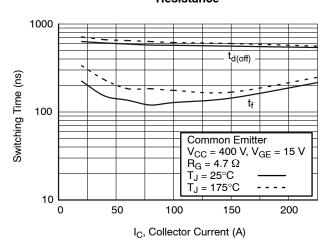


Figure 11. Turn-On Characteristics vs. Collector Current

Figure 12. Turn-Off Characteristics vs. Collector Current

TYPICAL CHARACTERISTICS (continued)

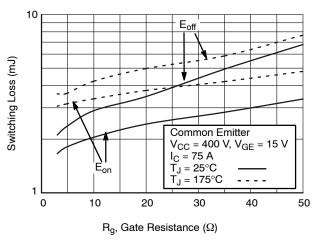


Figure 13. Switching Loss vs. Gate Resistance

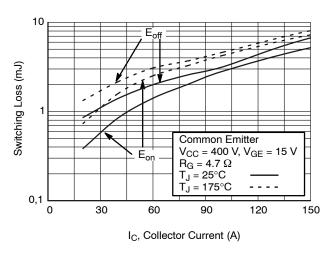


Figure 14. Switching Loss vs. Collector Current

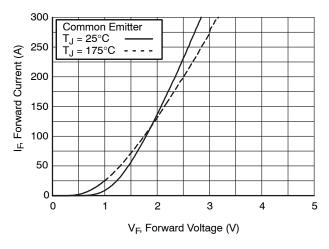


Figure 15. Forward Characteristics

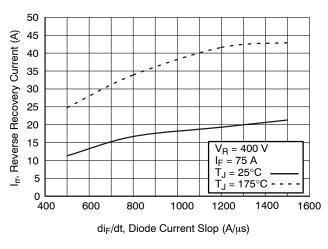


Figure 16. Reverse Recovery Current

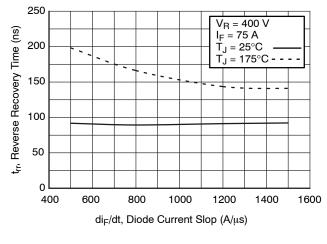


Figure 17. Reverse Recovery Time

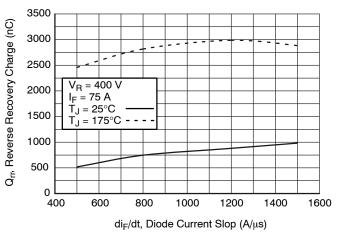


Figure 18. Stored Charge

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

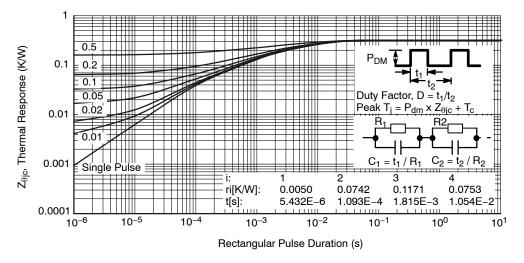


Figure 19. Transient Thermal Impedance of IGBT

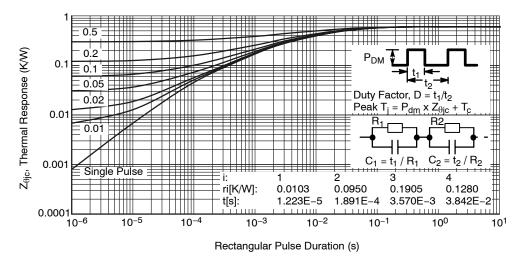
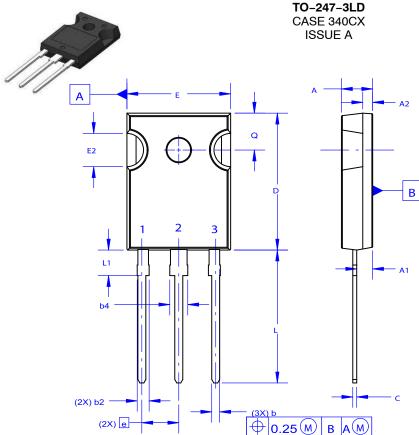
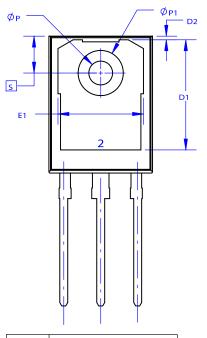


Figure 20. Transient Thermal Impedance of Diode



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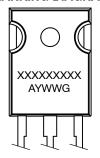


NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.

 B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " =", may or may not be present. Some products may not follow the Generic Marking.

DIM	MIL	MILLIMETERS			
DIM	MIN	NOM	MAX		
Α	4.58	4.70	4.82		
A 1	2.20	2.40	2.60		
A2	1.40	1.50	1.60		
D	20.32	20.57	20.82		
Е	15.37	15.62	15.87		
E2	4.96	5.08	5.20		
е	~	5.56	~		
L	19.75	20.00	20.25		
L1	3.69	3.81	3.93		
ØΡ	3.51	3.58	3.65		
Q	5.34	5.46	5.58		
S	5.34	5.46	5.58		
b	1.17	1.26	1.35		
b2	1.53	1.65	1.77		
b4	2.42	2.54	2.66		
С	0.51	0.61	0.71		
D1	13.08	~	~		
D2	0.51	0.93	1.35		
E1	12.81	~	~		
ØP1	6.60	6.80	7.00		

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